Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/070,617	SAKUMA, EMIKO	
Examiner	Art Unit	
Jacob Meek	2637	

	SEAR	SEARCHED			
Class	Subclass	Date	Examiner		
375	142,150 367,148 134,137 143,152	8/5/2005	JM		
370	335, 342	8/5/2005	JM		
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INT	ERFERENC	CE SEARCH	ED
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SEAR (INCLUDING S	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR		
East		8/4/2005	JM ·		
NPL		8/4/2005	JM		
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